

<b>Notice of References Cited</b>	Application/Control No. 09/110,678	Applicant(s)/Patent Under Reexamination MILLS, RANDELL L.	
	Examiner Stephen J. Kalafut	Art Unit 1745	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Luggenhölscher et al., "Investigations on Electric Field Distributions in a Microwave Discharge in Hyhydrogen" Internet URL <a href="http://www.phys.tue.nl/FLTPD/poster/luggenhoescher.pdf">http://www.phys.tue.nl/FLTPD/poster/luggenhoescher.pdf</a> (date unknown)
	V	Luque et al., "Experimental research into the influence of ion dynamics when measuring the electron density form the Stark broadening of the H-alpha and H-beta lines", Journal of Physics B: Atomic, Molecular and Optical Physics, v.36, p.1573-1584 (4/2003)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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